TOSHIBA Photocoupler GaAs IRed & Photo-Transistor

TLP531,TLP532

Programmable Controllers
AC / DC-Input Module
Solid State Relay

The TOSHIBA TLP531 and TLP532 consist of a photo–transistor optically coupled to a gallium arsenide infrared emitting diode in a six lead plastic DIP.

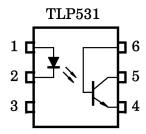
TLP532 is no-base internal connection for high-EMI environments.

- Collector-emitter voltage: 55 V (min.)
- Current transfer ratio: 50% (min.)

Rank GB: 100% (min.)

- Isolation voltage: 2500 V_{rms} (min.)
- UL recognized: UL1577, file no. E67349

Pin Configurations (top view)



1: ANODE

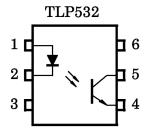
2: CATHODE

3 : N.C.

4: EMITTER

5: COLLECTOR

6: BASE



1: ANODE

2: CATHODE

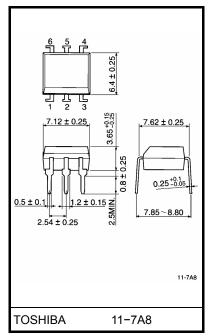
3 : N.C.

4 : EMITTER

5 : COLLECTOR

6 : N.C.

Unit in mm



Weight: 0.4g



Absolute Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit	
	Forward current	l _F	70	mA	
	Forward current derating (Ta ≥ 50°C)	ΔI _F / °C	0.93	mA / °C	
LED	Peak forward current (100 µs pulse, 100pps)	I _{FP}	1	Α	
7	Reverse voltage	V _R	5	V	
	Junction temperature	Tj	125	°C	
	Collector–emitter voltage	V _{CEO}	55	V	
	Collector-base voltage (TLP531)	V_{CBO}	80	V	
	Emitter-collector voltage	V _{ECO}	7	V	
ctor	Emitter-base voltage (TLP531)	V _{EBO}	7	V	
Detector	Collector current	IC	50	mA	
	Power dissipation	PC	150	mW	
	Power dissipation derating (Ta ≥ 25°C)	ΔP _C / °C	-1.5	mW / °C	
	Junction temperature	Tj	125	°C	
Storage temperature range		T _{stg}	-55~125	°C	
Operating temperature range		T _{opr}	-55~100	°C	
Lead soldering temperature (10s)		T _{sol}	260	°C	
Total package power dissipation		PT	250	mW	
Total package power dissipation derating (Ta ≥ 25°C)		ΔP _T / °C	-2.5	mW / °C	
Isolatio	on voltage (AC, 1min., R.H.≤ 60%)	BVS	2500	V _{rms}	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Recommends Operating Conditions

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V _{CC}	-	5	24	V
Forward current	lF	_	16	25	mA
Collector current	IC	_	1	10	mA
Operating temperature	T _{opr}	-25	_	85	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.



Individual Electrical Characteristics (Ta = 25°C)

	Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
LED	Forward voltage	V _F	I _F = 10mA	1.0	1.15	1.3	V
	Reverse current	I _R	V _R = 5V	_	_	10	μA
	Capacitance	C _T	V = 0, f = 1MHz	_	30	_	pF
	Collector–emitter breakdown voltage	V (BR) CEO	I _C = 0.5mA	55	_	_	V
Detector	Emitter-collector breakdown voltage	V (BR) ECO	I _E = 0.1mA	7	_	_	V
	Collector-base breakdown voltage (TLP531)	V (BR) CBO	I _C = 0.1mA	80	_	_	V
	Emitter-base breakdown voltage (TLP531)	V (BR) EBO	I _E = 0.1mA	7	_	_	V
	Collector dark current		V _{CE} = 24V	_	10	100	nA
	Collector dark current	ICEO	V _{CE} = 24V, Ta = 85°C	_	2	50	μA
	Capacitance (collector to emitter)	C _{CE}	V = 0, f = 1MHz	_	10	_	pF

Coupled Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	on	Min.	Тур.	Max.	Unit
		I _F = 5mA, V _{CE} = 5V		50	200	600	
			Rank Y	50	_	150	
Current transfer ratio	Rank GB 100 —		Rank YG	50	_	300	%
Current transfer fatto			Rank GR	100	_	300	70
		-	600				
			Rank BL	200	_	600	
Collector-emitter saturation voltage	V _{CE (sat)}	I _C = 2.4mA, I _F = 8mA		_	_	0.4	V



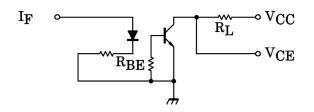
Isolation Characteristics (Ta = 25°C)

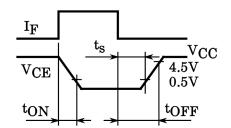
Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Capacitance (input to output)	CS	$V_S = 0$, $f = 1MHz$	_	0.8	_	pF
Isolation resistance	R _S	V _S = 500V, R.H.≤ 60%	5 × 10 ¹⁰	10 ¹⁴	_	Ω
Isolation voltage	BVS	AC, 1 minute	2500	_	_	V _{rms}

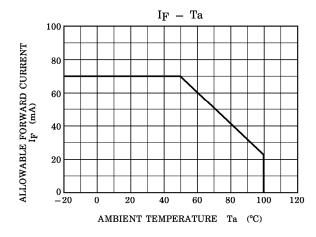
Switching Characteristics (Ta = 25°C)

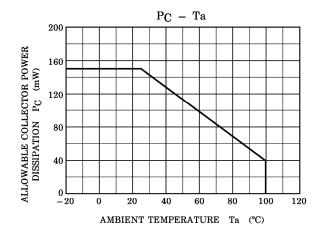
Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Rise time	t _r	V _{CC} = 10V	_	2	_	
Fall time	t _f		_	3	_	110
Turn-on time	t _{ON}	$I_C = 2mA$ $R_L = 100\Omega$	_	3	_	μs
Turn-off time	tOFF		_	3	_	
Turn-on time	t _{ON}	$R_L = 1.9k\Omega$ (Fig.1)	_	2	_	
Storage time	t _S	R _{BE} = open	_	15	_	μs
Turn-off time	t _{OFF}	V _{CC} = 5V, I _F = 16mA	_	25	_	
Turn-on time	t _{ON}	$R_L = 1.9\Omega$ (Fig.1)	_	2	_	
Storage time	t _s	$R_{BE} = 220k\Omega (TLP531)$	_	12	_	μs
Turn-off time	t _{OFF}	V _{CC} = 5V, I _F = 16mA	_	20	_	

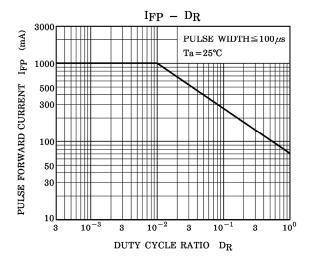
Fig. 1 Switching time test circuit

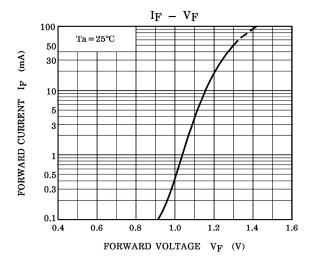


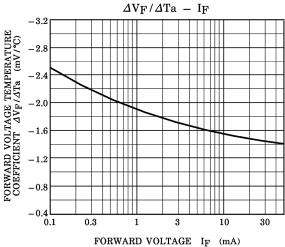


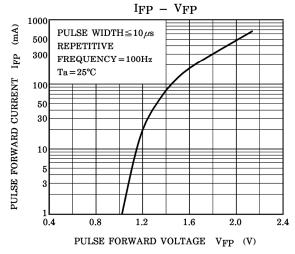


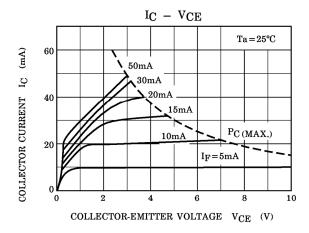


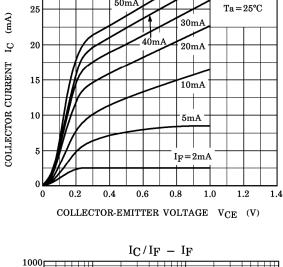






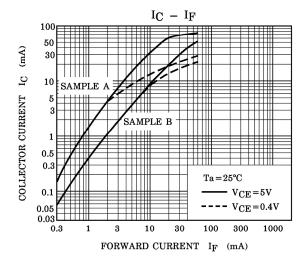


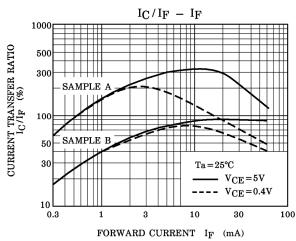


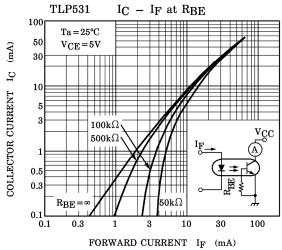


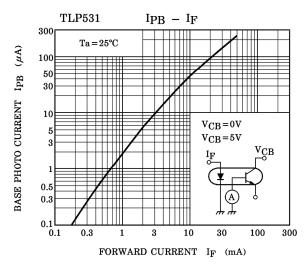
 $I_{C} - V_{CE}$

50mA

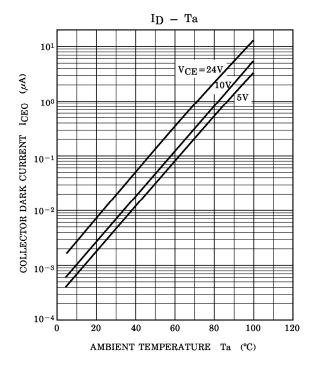


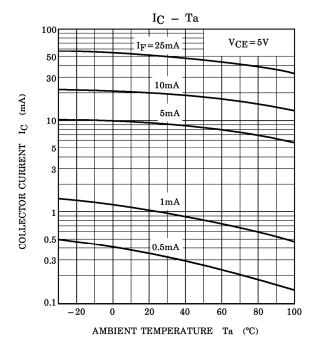


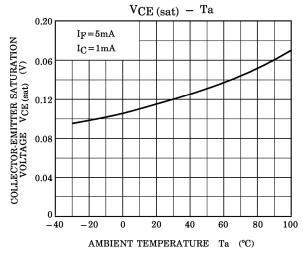


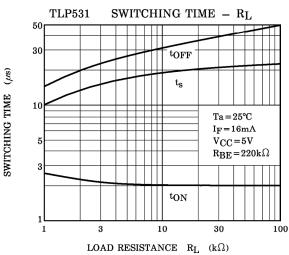


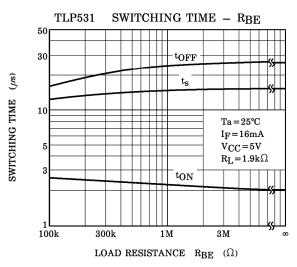
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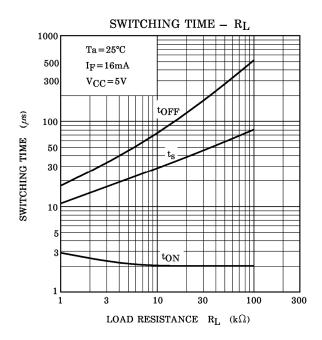












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RESTRICTIONS ON PRODUCT USE

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- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
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 that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses
 occurring as a result of noncompliance with applicable laws and regulations.